

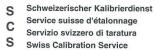


# Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland







Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

#### Glossary

DAE data acquisition electronics

Connector angle information used in DASY system to align probe sensor X to the robot

coordinate system.

#### Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
  - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
  - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
  - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
  - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
  - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
  - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
  - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
  - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
  - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE4-1525\_Oct17



## **DC Voltage Measurement**

A/D - Converter Resolution nominal

High Range:  $1LSB = 6.1\mu V$ , full range = -100...+300 mVLow Range: 1LSB = 61nV, full range = -1......+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	Х	Y	Z
High Range	405.912 ± 0.02% (k=2)	405.954 ± 0.02% (k=2)	405.400 ± 0.02% (k=2)
Low Range	3.99166 ± 1.50% (k=2)	4.00980 ± 1.50% (k=2)	3.99550 ± 1.50% (k=2)

#### **Connector Angle**

Connector Angle to be used in DASY system	53.5 ° ± 1 °
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# Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	200030.95	-2.42	-0.00
Channel X	+ Input	20004.11	-0.05	-0.00
Channel X	- Input	-20003.75	2.02	-0.01
Channel Y	+ Input	200031.20	-2.23	-0.00
Channel Y	+ Input	20001.46	-2.74	-0.01
Channel Y	- Input	-20005.92	-0.05	0.00
Channel Z	+ Input	200032.03	-1.05	-0.00
Channel Z	+ Input	20001.94	-2.11	-0.01
Channel Z	- Input	-20006.15	-0.20	0.00

Low Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	2000.66	0.19	0.01
Channel X	+ Input	200.40	-0.18	-0.09
Channel X	- Input	-198.67	0.81	-0.40
Channel Y	+ Input	2000.90	0.48	0.02
Channel Y	+ Input	199.98	-0.58	-0.29
Channel Y	- Input	-200.18	-0.62	0.31
Channel Z	+ Input	2000.68	0.32	0.02
Channel Z	+ Input	199.07	-1.45	-0.72
Channel Z	- Input	-201.14	-1.52	0.76

## 2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	18.32	16.76
	- 200	-15.73	-17.08
Channel Y	200	-20.47	-20.86
2	- 200	20.66	20.31
Channel Z	200	13.43	13.46
	- 200	-15.65	-15.97

## 3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200		0.08	-3.66
Channel Y	200	7.12		1.80
Channel Z	200	10.44	4.52	

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15817	15005
Channel Y	16329	14457
Channel Z	15576	15478

#### 5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.63	-0.54	2.27	0.51
Channel Y	-2.07	-3.42	-1.02	0.49
Channel Z	-0.89	-2.38	0.83	0.54

#### 6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



## **ANNEX J** Accreditation Certificate

United States Department of Commerce National Institute of Standards and Technology



# Certificate of Accreditation to ISO/IEC 17025:2005

NVLAP LAB CODE: 600118-0

## **Telecommunication Technology Labs, CAICT**

Beijing China

is accredited by the National Voluntary Laboratory Accreditation Program for specific services, listed on the Scope of Accreditation, for:

#### **Electromagnetic Compatibility & Telecommunications**

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005.

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communique dated January 2009).

2016-09-29 through 2017-09-30

Effective Dates



For the National Voluntary Laboratory Accreditation Program